## Notice of References Cited Application/Control No. 10/711,415 Examiner Dwayne J. White Applicant(s)/Patent Under Reexamination TAKESHITA ET AL. Page 1 of 1

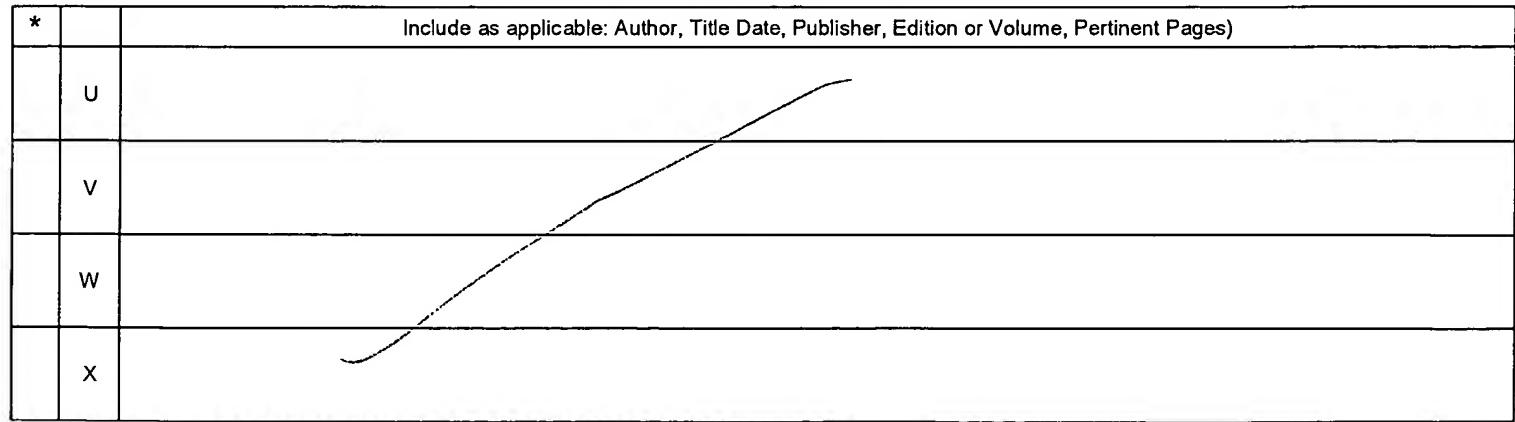
## **U.S. PATENT DOCUMENTS**

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## FOREIGN PATENT DOCUMENTS

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